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c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
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Attorney Docket Number	4641-59261
Application Number	09/881,445
Filing Date	June 13, 2001
First Named Inventor	Ushio
Art Unit	2818
Examiner Name	Not yet assigned

## **U.S. PATENT DOCUMENTS**

Examiner's Initials*	Cite No. (optional)	Number	Date	Name
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-		4,744,660	May 17, 1988	Noguchi et al.
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		56-153207	Nov. 27, 1981			
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		64-57107	March 3, 1989	Japan (w/English translation of relevant part)		
		6-147838	May 27, 1994	Japan (w/English translation)		

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<sup>\*</sup> Examiner: Initial if reference considered, whether or not in conformance with MPEP 609. Draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT First Named Inventor Ushio Art Unit Examiner Name Not y	yet assigned									
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